

Application/Control No.
10/722,837
Examiner
Ahmed M. Farah

•	Applicant(s)/Pate Reexamination	ent under
	WANG ET AL.	
	Art Unit	
	3735	

	SEAR	CHED	
Class	Subclass	Date	Examiner
606	10-18, 32- 52	3/6/2006	AF
607	88,89,96,		
704	3,4,233		
	200-210		
	251-255		
	270,275		
600	101-104		
	106-109		
	114,118		
901	2-9,30		
	36,46		
414	02		
381	110	P	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	ce Search Printout	3/6/2006	AF

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor Search; and EAST search: Classification (IS&R); and Text (BRS)	3/6/2006	AF
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	3/6/2006	AF
See the attached "Search History."	3/6/2006	AF